

Digital Power Monitor with Clear Pin and ALERT Output

ADM1192

FEATURES

Powered from 3.15 V to 26 V
Precision current sense amplifier
Precision voltage input
12-bit ADC for current and voltage readback
ALERT output allows basic P-channel FET hot swap up to 26 V

SETV input for setting overcurrent alert threshold Programmable overcurrent filtering via TIMER pin CLRB input pin

 I^2C° fast mode-compliant interface (400 kHz maximum) 10-lead MSOP

APPLICATIONS

Power monitoring/power budgeting
Central office equipment
Telecommunication and data communication equipment
PCs/servers

GENERAL DESCRIPTION

The ADM1192 is an integrated current sense amplifier that offers digital current and voltage monitoring via an on-chip, 12-bit analog-to-digital converter (ADC), communicated through an I²C interface.

An internal current sense amplifier senses voltage across the sense resistor in the power path via the VCC pin and the SENSE pin.

A 12-bit ADC can measure the current seen in the sense resistor and in the supply voltage on the VCC pin. An industry-standard I²C interface allows a controller to read current and voltage data from the ADC. Measurements can be initiated by an I²C command. Alternatively, the ADC can run continuously, and the user can read the latest conversion data whenever it is required. Up to four unique I²C addresses can be created, depending on the way the ADR pin is connected.

A SETV pin is also included. A voltage applied to this pin is internally compared to the output voltage on the current sense amplifier. The output of the SETV comparator asserts when the current sense amplifier output exceeds the SETV voltage. This event is detected at the ALERT block. The ALERT block then charges up the external TIMER capacitor with a fixed current. When this timing cycle is complete, the ALERT output asserts.

FUNCTIONAL BLOCK DIAGRAM

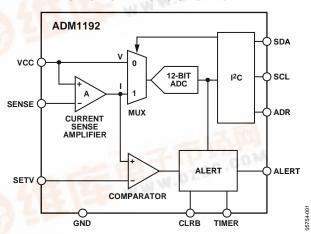


Figure 1.

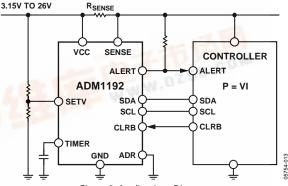


Figure 2. Applications Diagram

The ALERT output can be used as a flag to warn a microcontroller or field programmable gate array (FPGA) of an overcurrent condition. ALERT outputs of multiple ADM1192 devices can be tied together and used as a combined alert.

A basic P-channel FET hot swap circuit can be implemented with the ALERT output. The value of the TIMER capacitor should be set so that the charging time of this capacitor is much longer than the period where a higher than nominal inrush current may be flowing.

The ADM1192 is packaged in a 10-lead MSOP.

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REVISION HISTORY

9/06—Revision 0: Initial Version

SPECIFICATIONS

 V_{CC} = 3.15 V to 26 V; T_A = -40° C to +85°C; typical values at T_A = 25°C, unless otherwise noted. **Table 1.**

| Table 1. | D. 0. | T . | | 11 | C 1141 - | |
|---|------------|------------|---------|---------|---|--|
| Parameter | Min | Тур | Max | Unit | Conditions | |
| VCC PIN Operating Voltage Range, Vvcc Supply Current, Icc | 3.15 | 1.7 | 26 2 | V mA | | |
| Undervoltage Lockout, Vuvlo Undervoltage Lockout Hysteresis, Vuvlohyst | | 2.8 80 | | V mV | V _{CC} rising | |
| MONITORING ACCURACY ¹ | | | | | | |
| Current Sense Absolute Accuracy | -1.45 | | +1.45 | % | $V_{SENSE} = 75 \text{ mV}$ | 0°C to +70°C |
| | -1.8 | | +1.8 | % | $V_{SENSE} = 50 \text{ mV}$ | 0°C to +70°C |
| | -2.8 | | +2.8 | % | $V_{SENSE} = 25 \text{ mV}$ | 0°C to +70°C |
| | -5.7 | | +5.7 | % | $V_{SENSE} = 12.5 \text{ mV}$ | 0°C to +70°C |
| | -1.5 | | +1.5 | % | V _{SENSE} = 75 mV | 0°C to +85°C |
| | -1.8 | | +1.8 | % | $V_{SENSE} = 50 \text{ mV}$ | 0°C to +85°C |
| | -2.95 | | +2.95 | % | V _{SENSE} = 25 mV | 0°C to +85°C |
| | -6.1 | | +6.1 | % | V _{SENSE} = 12.5 mV | 0°C to +85°C |
| | -1.95 | | +1.95 | % | V _{SENSE} = 75 mV | -40°C to +85°C |
| | -2.45 | | +2.45 | % | $V_{SENSE} = 50 \text{ mV}$ | -40°C to +85°C |
| | -3.85 | | +3.85 | % | V _{SENSE} = 25 mV | -40°C to +85°C |
| | -6.7 | | +6.7 | % | V _{SENSE} = 12.5 mV | -40°C to +85°C |
| V _{SENSE} for ADC Full Scale | | 105.84 | | mV | | es to current readings; s value is factored into uracy values (see use Absolute |
| Voltage Sense Accuracy | -0.85 | | +0.85 | % | $V_{VCC} = 3.0 \text{ V to } 5.5 \text{ V}$ (low range) | 0°C to +70°C |
| | -0.9 | | +0.9 | % | $V_{VCC} = 10.8 \text{ V to}$ 16.5 V (high range) | 0°C to +70°C |
| | -0.85 | | +0.85 | % | $V_{VCC} = 3.0 \text{ V to } 5.5 \text{ V}$ (low range) | 0°C to +85°C |
| | -0.9 | | +0.9 | % | V _{VCC} = 10.8 V to 16.5 V (high range) | 0°C to +85°C |
| | -0.9 | | +0.9 | % | $V_{VCC} = 3.0 \text{ V to } 5.5 \text{ V}$ (low range) | -40°C to +85°C |
| | -1.15 | | +1.15 | % | $V_{VCC} = 10.8 \text{ V to}$ 16.5 V (high range) | -40°C to +85°C |
| V_{CC} for ADC Full Scale, Low Range (VRANGE = 1) | | 6.65 | | V | converting ADC code | alues to be used when es to voltage readings; |
| V_{CC} for ADC Full Scale, High Range (VRANGE = 0) | | 26.52 | | V | any inaccuracy in the into voltage accuracy Voltage Accuracy) | se values is factored values (see specs for |
| CLRB PIN | | | | | | |
| Logic Low Threshold, V _{CLRBL} | | _ | 8.0 | V | | |
| Input Current for Logic Low Input, I _{CLRBL} | -40 1.6 | -22 | | μA | $V_{CLRB} = 0 V \text{ to } 0.8 V$ | |
| Logic High Threshold, V _{CLRBH} Input Current for Logic High Input, I _{CLRBH} | 1.6 | 3 | 6 | mV | $V_{CLRB} = 1.6 \text{ V to } 5.5 \text{ V}$ | |
| SENSE PIN | | ی | U | μΑ | v CLRB — 1.0 v (O 3.3 V | |
| Input Current, Isense | -1 | | +1 | μΑ | $V_{SENSE} = V_{VCC}$ | |
| In the second control | <u> </u> | | | 1 | 32.132 - 700 | |

| Parameter | Min | Тур | Max | Unit | Conditions |
|--|----------------------------|------|---------------------|-------|---|
| SETV PIN | | | | | |
| Overcurrent Trip Threshold | 98 | 100 | 102 | mV | V _{SETV} = 1.8 V |
| · | 49.5 | 50 | 50.5 | mV | $V_{SETV} = 0.9 V$ |
| Overcurrent Trip, Gain {Vsetv/(Vvcc - Vsense)} | | 18 | | | $V_{SETV} = 0.9 \text{ V to } 1.9 \text{ V}$ |
| Input Current, I _{SETVLEAK} | -1 | | +1 | μΑ | $V_{SETV} = 0.9 \text{ V to } 1.9 \text{ V}$ |
| Glitch Filter, tsetvglitch | | 3 | | μs | |
| TIMER PIN | | | | - | |
| Pull-Up Current (Overcurrent Fault), ITIMERUPOC | -46 | -62 | -78 | μΑ | $(18.125 \times V_{SENSE}) > V_{SETV}, V_{TIMER} = 1 V$ |
| Pull-Down Current, I _{TIMERDN} | | 100 | | μA | Normal Operation, V _{TIMER} = 1 V |
| Pin Threshold High, V _{TIMERH} | 1.275 | 1.3 | 1.325 | V | TIMER rising |
| ALERT PIN | | | | | |
| Output Low Voltage, VALERTOL | | 0.05 | 0.1 | V | $I_{ALERT} = -100 \mu A$ |
| 3.7, | | 1 | 1.5 | mA | $I_{ALERT} = -2 \text{ mA}$ |
| Input Current, I _{ALERT} | -1 | | +1 | μA | $V_{ALERT} = V_{CC}$; ALERT asserted |
| ADR PIN | | | | Par 1 | TALLIN TOO, TELLIN STORY |
| Set Address to 00, V _{ADRLOWV} | 0 | | 0.8 | V | Low state |
| Set Address to 01, Radrilowz | 80 | 120 | 160 | kΩ | Resistor to ground state, load pin with |
| Set Madress to 01, Markows | | 120 | 100 | 1422 | specified resistance for 01 decode |
| Set Address to 10, I _{ADRHIGHZ} | -0.3 | | +0.3 | μΑ | Open state, maximum load allowed on ADR pin for 10 decode |
| Set Address to 11, V _{ADRHIGHV} | 2 | | 5.5 | V | High state |
| Input Current for 00 Decode, IADRLOW | | 3 | 6 | μΑ | V _{ADR} = 2.0 V to 5.5 V |
| Input Current for 11 Decode, IADRHIGH | -40 | -25 | | μΑ | $V_{ADR} = 0 V \text{ to } 0.8 V$ |
| I ² C TIMING | | | | | |
| Low Level Input Voltage, V _{IL} | | | $0.3V_{\text{BUS}}$ | V | |
| High Level Input Voltage, V _H | 0.7 V _{BUS} | | | V | |
| Low Level Output Voltage on SDA, Vol | | | 0.4 | V | $I_{OL} = 3 \text{ mA}$ |
| Output Fall Time on SDA from VIHMIN to VILMAX | 20 + 0.1 C _B | | 250 | ns | C _B = bus capacitance from SDA to GND |
| Maximum Width of Spikes Suppressed by Input Filtering on SDA and SCL Pins | 50 | | 250 | ns | |
| Input Current, I _i , on SDA/SCL When not Driving Out a Logic Low | -10 | | +10 | μΑ | |
| Input Capacitance on SDA/SCL | | 5 | | рF | |
| SCL Clock Frequency, f _{SCL} | | - | 400 | kHz | |
| Low Period of the SCL Clock | 600 | | • | ns | |
| High Period of the SCL Clock | 1300 | | | ns | |
| Setup Time for Repeated Start Condition, tsu;sta | 600 | | | ns | |
| SDA Output Data Hold Time, tho;DAT | 100 | | 900 | ns | |
| Setup Time for a Stop Condition, tsu,sto | 600 | | | ns | |
| Bus Free Time Between a Stop and a Start | 1300 | | | ns | |
| Condition, t _{BUF} | | | 400 | | |
| Capacitive Load for Each Bus Line | | | 400 | pF | |

¹ Monitoring accuracy is a measure of the error in a code that is read back for a particular voltage/current. This is a combination of amplifier error, reference error, ADC error, and error in ADC full-scale code conversion factor.

ABSOLUTE MAXIMUM RATINGS

Table 2

| Parameter | Rating |
|-------------------------------------|-----------------|
| VCC Pin | 30 V |
| SENSE Pin | 30 V |
| TIMER Pin | −0.3 V to +6 V |
| CLRB Pin | −0.3 V to +6 V |
| SETV Pin | 30 V |
| ALERT Pin | 30 V |
| SDA Pin, SCL Pin | −0.3 V to +6 V |
| ADR Pin | −0.3 V to +6 V |
| Storage Temperature Range | −65°C to +125°C |
| Operating Temperature Range | −40°C to +85°C |
| Lead Temperature (Soldering 10 sec) | 300°C |
| Junction Temperature | 150°C |

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

THERMAL CHARACTERISTICS

 θ_{JA} is specified for the worst-case conditions, that is, a device soldered in a circuit board for surface-mount packages.

Table 3. Thermal Resistance

| Package Type | θ _{JA} | Unit |
|--------------|-----------------|------|
| 10-Lead MSOP | 137.5 | °C/W |

ESD CAUTION



ESD (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

PIN CONFIGURATION AND FUNCTION DESCRIPTIONS

ADM1192ARM

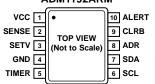


Figure 3. Pin Configuration

Table 4. Pin Function Descriptions

| Pin No. | Mnemonic | Description |
|---------|----------|---|
| 1 | VCC | Positive Supply Input Pin. The operating supply voltage range is 3.15 V to 26 V. An undervoltage lockout (UVLO) circuit resets the ADM1192 when a low supply voltage is detected. |
| 2 | SENSE | Current Sense Input Pin. A sense resistor between the VCC pin and the SENSE pin generates a voltage across a sense resistor. This voltage is proportional to the load current. A current sense amplifier amplifies this voltage before it is digitized by the ADC. |
| 3 | SETV | Input Pin. The voltage driven onto this pin is compared to the output of the internal current sense amplifier. The lower the voltage on the SETV, the lower the current level that causes the ALERT output to assert. |
| 4 | GND | Chip Ground Pin. |
| 5 | TIMER | Timer Input Pin. An external capacitor, C _{TIMER} , sets the timing period for masking overcurrent conditions. This timing period should be sufficient to allow the load charge up completely with maximum current at startup without tripping an overcurrent fault. |
| 6 | SCL | I ² C Clock Pin. Open-drain input; requires an external resistive pull-up. |
| 7 | SDA | I ² C Data I/O Pin. Open-drain input/output; requires an external resistive pull-up. |
| 8 | ADR | I ² C Address Pin. This pin can be tied low, tied high, left floating, or tied low through a resistor to set four different I ² C addresses. |
| 9 | CLRB | Clear Pin. A latched overcurrent condition can be cleared by pulling this pin low. |
| 10 | ALERT | Alert Output Pin. Active high, open-drain configuration. This pin asserts high when an overcurrent condition is present. The level at which an overcurrent condition is detected depends on the voltage on the SETV pin. |

TYPICAL PERFORMANCE CHARACTERISTICS

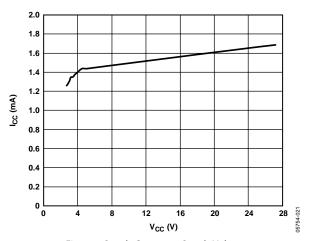


Figure 4. Supply Current vs. Supply Voltage

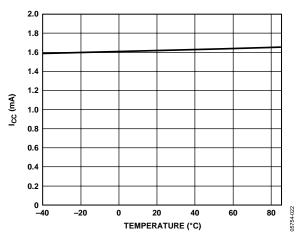


Figure 5. Supply Current vs. Temperature

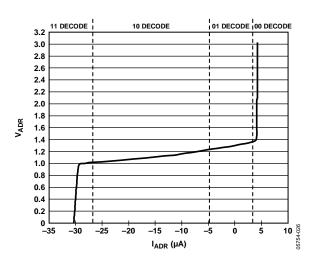


Figure 6. Address Pin Voltage vs. Address Pin Current for Four Addressing Options

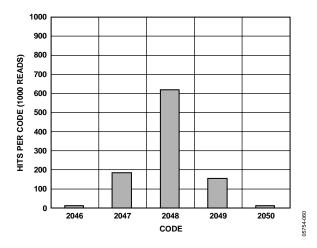


Figure 7. ADC Noise, Current Channel, Midcode Input, 1000 Reads

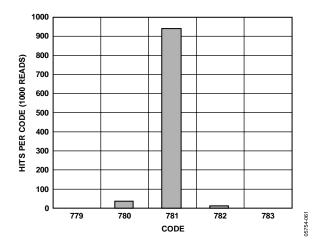


Figure 8. ADC Noise, 14:1 Voltage Channel, 5 V Input, 1000 Reads

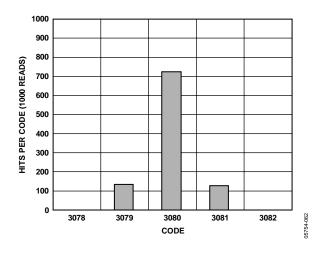


Figure 9. ADC Noise, 7:1 Voltage Channel, 5 V Input, 1000 Reads

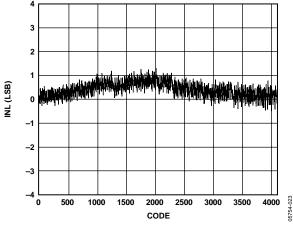


Figure 10. INL for ADC

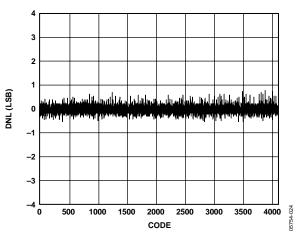


Figure 11. DNL for ADC

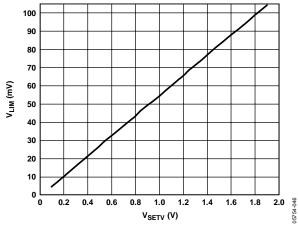


Figure 12. VLIM vs. VSETV

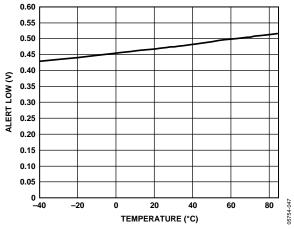


Figure 13. ALERT Output Low Voltage vs. Temperature @ 1 mA

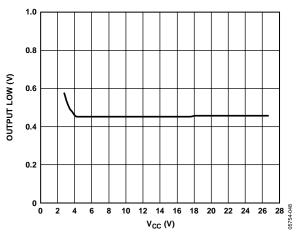


Figure 14. ALERT Output Low Voltage vs. Supply @ 1 mA

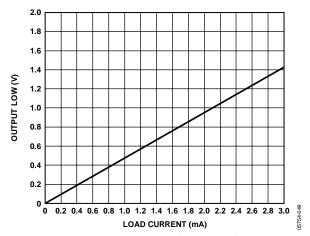


Figure 15. ALERT Output Low Voltage vs. Load Current

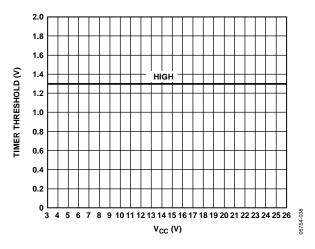


Figure 16. Timer Threshold vs. Supply Voltage

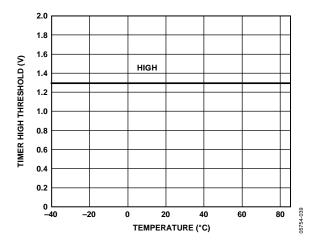


Figure 17. Timer Threshold vs. Temperature

VOLTAGE AND CURRENT READBACK

The ADM1192 contains the components to allow voltage and current readback over an Inter-IC (I²C) bus. The voltage output of the current sense amplifier and the voltage on the VCC pin are fed into a 12-bit ADC via a multiplexer. The device can be instructed to convert voltage and/or current at any time during operation via an I²C command. When all conversions are complete, the voltage and/or current values can be read out to 12-bit accuracy in two or three bytes.

SERIAL BUS INTERFACE

Control of the ADM1192 is carried out via the serial system management bus (I²C). This interface is compatible with I²C fast mode (400 kHz maximum). The ADM1192 is connected to this bus as a slave device, under the control of a master device.

IDENTIFYING THE ADM1192 ON THE I²C BUS

The ADM1192 has a 7-bit serial bus slave address. When the device powers up, it does so with a default serial bus address. The five MSBs of the address are set to 01011; the two LSBs are determined by the state of the ADR pin. There are four different configurations available on the ADR pin that correspond to four different I²C addresses for the two LSBs (see Table 5). This scheme allows four ADM1192 devices to operate on a single I²C.

Table 5. Setting I²C Addresses via the ADR Pin

| ADR Configuration | Address |
|------------------------|---------|
| Low state | 0x68 |
| Resistor to GND | 0x69 |
| Floating (unconnected) | 0x6A |
| High state | 0x6B |

GENERAL I²C TIMING

Figure 18 and Figure 19 show timing diagrams for general read and write operations using the I²C. The I²C specification defines conditions for different types of read and write operations, which are discussed later. The general I²C protocol operates as follows:

1. The master initiates data transfer by establishing a start condition, defined as a high-to-low transition on the serial data line, SDA, while the serial clock line, SCL, remains high. This indicates that a data stream follows. All slave peripherals connected to the serial bus respond to the start condition and shift in the next eight bits, consisting of a 7-bit slave address (MSB first) plus an R/\overline{W} bit that determines the direction of the data transfer; that is, whether data is written to or read from the slave device (0 = write, 1 = read).

The peripheral whose address corresponds to the transmitted address responds by pulling the data line low during the low period before the ninth clock pulse, known as the acknowledge bit, and holding it low during the high period of this clock pulse. All other devices on the bus now remain idle while the selected device waits for data to be read from it or written to it. If the R/\overline{W} bit is 0, the master writes to the slave device. If the R/\overline{W} bit is 1, the master reads from the slave device.

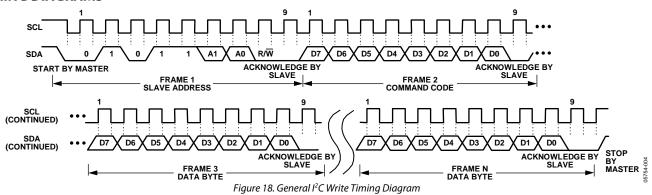
Data is sent over the serial bus in sequences of nine clock pulses: eight bits of data followed by an acknowledge bit from the slave device. Data transitions on the data line must occur during the low period of the clock signal and remain stable during the high period because a low-to-high transition when the clock is high can be interpreted as a stop signal.

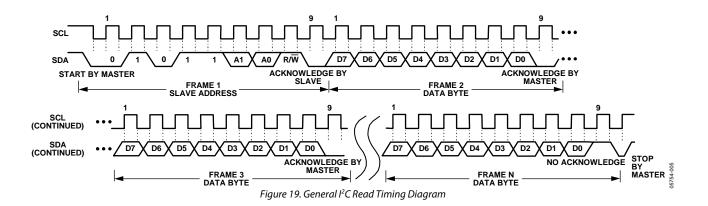
If the operation is a write operation, the first data byte after the slave address is a command byte. This tells the slave device what to expect next. It can be an instruction, such as telling the slave device to expect a block write, or it can be a register address that tells the slave where subsequent data is to be written.

Because data can flow in only one direction, as defined by the R/W bit, it is not possible to send a command to a slave device during a read operation. Before doing a read operation, it may first be necessary to do a write operation to tell the slave what sort of read operation to expect and/or the address from which data is to be read.

3. When all data bytes have been read or written, stop conditions are established. In write mode, the master pulls the data line high during the 10th clock pulse to assert a stop condition. In read mode, the master device releases the SDA line during the low period before the ninth clock pulse, but the slave device does not pull it low. This is known as a no acknowledge. The master then takes the data line low during the low period before the 10th clock pulse, then high during the 10th clock pulse to assert a stop condition.

TIMING DIAGRAMS





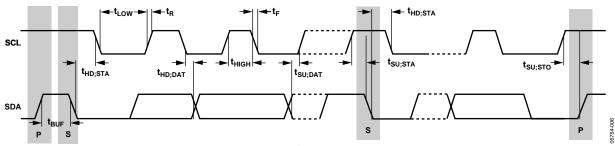


Figure 20. Serial Bus Timing Diagram

WRITE AND READ OPERATIONS

The I²C specification defines several protocols for different types of read and write operations. The operations used in the ADM1192 are discussed in the sections that follow. Table 6 shows the abbreviations used in the command diagrams.

Table 6. I²C Abbreviations

| Abbreviation | Condition |
|--------------|----------------|
| S | Start |
| P | Stop Read |
| R | Read |
| W | Write |
| A | Acknowledge |
| N | No acknowledge |

QUICK COMMAND

The quick command operation allows the master to check if the slave is present on the bus, as follows:

- 1. The master device asserts a start condition on SDA.
- 2. The master sends the 7-bit slave address, followed by the write bit (low).
- 3. The addressed slave device asserts an acknowledge on SDA.

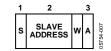


Figure 21. Quick Command

WRITE COMMAND BYTE

In the write command byte operation, the master device sends a command byte to the slave device, as follows:

- 1. The master device asserts a start condition on SDA.
- 2. The master sends the 7-bit slave address, followed by the write bit (low).
- 3. The addressed slave device asserts an acknowledge on SDA.
- 4. The master sends the command byte. The command byte is identified by an MSB = 0. An MSB = 1 indicates an extended register write (see the Write Extended Byte section).
- 5. The slave asserts an acknowledge on SDA.
- 6. The master asserts a stop condition on SDA to end the transaction.

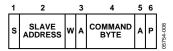


Figure 22. Write Command Byte

The seven LSBs of the command byte are used to configure and control the ADM1192. Table 7 provides details of the function of each bit.

Table 7. Command Byte Operations

| 140 | Tuble 7. Communa Byte operations | | | | | | |
|-----|----------------------------------|-----------|---|--|--|--|--|
| Bit | Default | Name | Function | | | | |
| C0 | 0 | V_CONT | Set to convert voltage continuously. If readback is attempted before the first conversion is complete, the ADM1192 asserts an acknowledge and returns all 0s in the returned data. | | | | |
| C1 | 0 | V_ONCE | Set to convert voltage once. Self-clears. I ² C asserts a no acknowledge on attempted reads until ADC conversion is complete. | | | | |
| C2 | 0 | I_CONT | Set to convert voltage continuously. If readback is attempted before the first conversion is complete, the ADM1192 asserts an acknowledge and returns all 0s in the returned data. | | | | |
| C3 | 0 | I_ONCE | Set to convert current once. Self-clears. I ² C asserts a no acknowledge on attempted reads until ADC conversion is complete. | | | | |
| C4 | 0 | VRANGE | Selects different internal attenuation resistor networks for voltage readback. A 0 in C4 selects a 14:1 voltage divider. A 1 in C4 selects a 7:2 voltage divider. With an ADC full scale of 1.902 V, the voltage at the VCC pin for an ADC full-scale result is 26.52 V for VRANGE = 0 and 6.65 V for VRANGE = 1. | | | | |
| C5 | 0 | N/A | Unused. | | | | |
| C6 | 0 | STATUS_RD | Status Read. When this bit is set, the data byte read back from the ADM1192 is the STATUS byte. This contains the status of the device alerts. See Table 15 for full details of the STATUS byte. | | | | |

WRITE EXTENDED BYTE

In the write extended byte operation, the master device writes to one of the three extended registers of the slave device, as follows:

- 1. The master device asserts a start condition on SDA.
- 2. The master sends the 7-bit slave address, followed by the write bit (low).
- 3. The addressed slave device asserts an acknowledge on SDA.
- 4. The master sends the register address byte. The MSB of this byte is set to 1 to indicate an extended register write. The two LSBs indicate which of the three extended registers are to be written to (see Table 8). All other bits should be set to 0.
- The slave asserts an acknowledge on SDA.
- 6. The master sends the command byte. The command byte is identified by an MSB = 0. An MSB = 1 indicates an extended register write.

- 7. The slave asserts an acknowledge on SDA.
- 8. The master asserts a stop condition on SDA to end the transaction.



Figure 23. Write Extended Byte

Table 9, Table 10, and Table 11 give details of each extended register.

Table 8. Extended Register Addresses

| A6 | A5 | A4 | А3 | A2 | A 1 | A0 | Extended Register |
|----|----|----|----|----|------------|----|-------------------|
| 0 | 0 | 0 | 0 | 0 | 0 | 1 | ALERT_EN |
| 0 | 0 | 0 | 0 | 0 | 1 | 0 | ALERT_TH |
| 0 | 0 | 0 | 0 | 0 | 1 | 1 | CONTROL |

Table 9. ALERT_EN Register Operations

| Bit | Default | Name | Function |
|-----|---------|--------------|---|
| 0 | 0 | EN_ADC_OC1 | Enabled if a single ADC conversion on the I channel has exceeded the threshold set in the ALERT_TH register. |
| 1 | 0 | EN_ADC_OC4 | Enabled if four consecutive ADC conversions on the I channel have exceeded the threshold set in the ALERT_TH register. |
| 2 | 1 | EN_OC_ALERT | Enables the OC_ALERT register. If an overcurrent condition is present and the TIMER pin has charged to 1.3 V, the OC_ALERT register captures and latches this condition. |
| 3 | 0 | EN_OFF_ALERT | Enables an alert if the HS operation is turned off by an operation that writes the SWOFF bit high. This allows software override of the ALERT output and turns on a P-channel FET controlled by ALERT. |
| 4 | 0 | CLEAR | Clears the OC_ALERT and ADC_ALERT status bits in the status register. These may immediately reset if the source of the alert has not been cleared or disabled with the other bits in this register. This bit self-clears to 0 after the status register bits have been cleared. |

Table 10. ALERT TH Register Operations

| Bit | Default | Function |
|-----|---------|---|
| 7:0 | | The ALERT_TH register sets the current level at which an alert occurs. Defaults to ADC full scale. The ALERT_TH 8-bit number corresponds to the top eight bits of the current channel data. |

Table 11. CONTROL Register Operations

| Bit | Default | Name | Function |
|-----|---------|-------|---|
| 0 | 0 | SWOFF | Forces the ALERT pin to deassert. Can be active only if the EN_OFF_ALERT bit is high (see Table 9). |

READ VOLTAGE AND/OR CURRENT DATA BYTES

The ADM1192 can be set up to provide information in three different ways (see the Write Command Byte section). Depending on how the device is configured, the following data can be read out of the device after a conversion (or conversions).

Voltage and Current Readback

The ADM1192 digitizes both voltage and current. Three bytes are read out of the device in the format shown in Table 12.

Table 12. Voltage and Current Readback Format

| Byte | Contents | B7 | В6 | B5 | B4 | В3 | B2 | B1 | ВО |
|------|-----------------|-----|-----|----|----|----|----|------------|----|
| 1 | Voltage MSBs | V11 | V10 | V9 | V8 | V7 | V6 | V5 | V4 |
| 2 | Current MSBs | l11 | I10 | 19 | 18 | 17 | 16 | 15 | 14 |
| 3 | LSBs | V3 | V2 | V1 | V0 | 13 | 12 | I 1 | 10 |

Voltage Readback

The ADM1192 digitizes voltage only. Two bytes are read out of the device in the format shown in Table 13.

Table 13. Voltage Only Readback Format

| Byte | Contents | B7 | B6 | B5 | B4 | В3 | B2 | B1 | ВО |
|------|--------------|-----|-----|----|----|----|----|----|----|
| 1 | Voltage MSBs | V11 | V10 | V9 | V8 | V7 | V6 | V5 | V4 |
| 2 | Voltage LSBs | V3 | V2 | V1 | V0 | 0 | 0 | 0 | 0 |

Current Readback

The ADM1192 digitizes current only. Two bytes are read out of the device in the format shown in Table 14.

Table 14. Current Only Readback Format

| Byte | Contents | B7 | B6 | B5 | B4 | В3 | B2 | B1 | ВО |
|------|--------------|-----|-----|----|----|----|----|----|----|
| 1 | Current MSBs | l11 | l10 | 19 | 18 | 17 | 16 | 15 | 14 |
| 2 | Current LSBs | 13 | 12 | l1 | 10 | 0 | 0 | 0 | 0 |

The following series of events occurs when the master receives three bytes (voltage and current data) from the slave device:

- 1. The master device asserts a start condition on SDA.
- 2. The master sends the 7-bit slave address, followed by the read bit (high).
- 3. The addressed slave device asserts an acknowledge on SDA.
- 4. The master receives the first data byte.
- 5. The master asserts an acknowledge on SDA.
- 6. The master receives the second data byte.
- 7. The master asserts an acknowledge on SDA.
- 8. The master receives the third data byte.
- 9. The master asserts a no acknowledge on SDA.
- 10. The master asserts a stop condition on SDA, and the transaction ends.

For cases where the master is reading voltage only or current only, only two data bytes are read. Step 7 and Step 8 are not required.



Figure 24. Three-Byte Read from ADM1192



Figure 25. Two-Byte Read from ADM1192

Converting ADC Codes to Voltage and Current Readings

The following equations can be used to convert ADC codes representing voltage and current from the ADM1175 12-bit ADC into actual voltage and current values.

$$Voltage = (V_{FULLSCALE}/4096) \times Code$$

where

 $V_{\it FULLSCALE}$ = 6.65 (7:2 range) or 26.35 (14:1 range). *Code* is the ADC voltage code read from the device (Bit V0 to Bit V11).

 $Current = ((I_{FULLSCALE}/4096) \times Code)/Sense Resistor$

where:

 $I_{FULLSCALE} = 105.84 \text{ mV}.$

Code is the ADC current code read from the device (Bit I0 to Bit I11).

Read Status Register

A single register of status data can also be read from the ADM1192.

- 1. The master device asserts a start condition on SDA.
- 2. The master sends the 7-bit slave address, followed by the read bit (high).
- 3. The addressed slave device asserts an acknowledge on SDA.
- 4. The master receives the status byte.
- 5. The master asserts an acknowledge on SDA.

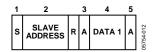


Figure 26. Status Read from ADM1192

Table 15 shows the ADM1192 status registers in detail. Note that Bit 1, Bit 3, and Bit 5 are cleared by writing to Bit 4 of the ALERT_EN register (CLEAR).

Table 15. Status Byte Operations

| Bit | Name | Function |
|-----|------------|--|
| 0 | ADC_OC | An ADC-based overcurrent comparison has been detected on the last three conversions. |
| 1 | ADC_ALERT | An ADC-based overcurrent trip has occurred, which has caused the alert. Cleared by writing to Bit 4 of the ALERT_EN register. |
| 2 | ОС | An overcurrent condition is present (that is, the output of the current sense amplifier is greater than the voltage on the SETV input). |
| 3 | OC_ALERT | An overcurrent condition has caused the ALERT block to latch a fault, and the ALERT output has asserted. Cleared by writing to Bit 4 of the ALERT_EN register. |
| 4 | OFF_STATUS | Set to 1 by writing to the SWOFF bit of the CONTROL register. |
| 5 | OFF_ALERT | An alert has been caused by the SWOFF bit. Cleared by writing to Bit 4 of the ALERT_EN register. |

ALERT OUTPUT

The ALERT output is an open-drain pin with 30 V tolerance. There are two uses for this output.

Overcurrent Flag

The ALERT pin can be connected to the general-purpose logic input of a controller. Under normal operation, the ADM1192 drives this output low. When an overcurrent condition occurs, the output asserts high. An external pull-up resistor should be used.

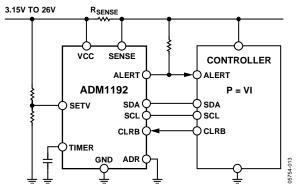


Figure 27. Using the ALERT Output as an Interrupt

Implementing a Basic Hot Swap Circuit

A basic P-channel FET hot swap circuit can be created. The ALERT output should be connected to the GATE pin of a P-channel FET connected in series with the power path. A pull-up from GATE to source ensures that the P-channel FET GATE is pulled up and the device held off as soon as power is applied. When the ADM1192 powers up, the GATE is pulled low by the ALERT output. A capacitor on the TIMER pin determines the slew rate of the GATE at turn-on. Note that if a current fault occurs at any point in operation, the ALERT output asserts high, turning off the P-channel FET.

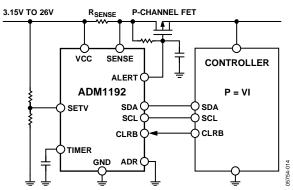


Figure 28. P-Channel FET Hot Swap Implementation

SETV PIN

The SETV pin allows the user to adjust the current level that trips the ALERT output. The output of the current sense amplifier is compared with the voltage driven onto the SETV pin. If the current sense amplifier output is higher than the SETV voltage, the output of the comparator asserts. By driving a different voltage onto the SETV pin, the ADM1192 detects an overcurrent condition at a different current level, with a gain of 18. See Figure 12 for an illustration of this relationship.

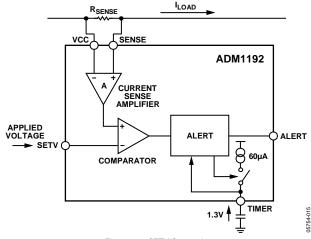


Figure 29. SETV Operation

When the output of the SETV comparator asserts, this tells the ALERT block to begin charging the external TIMER capacitor with a 60 μA charging current. When the voltage on the TIMER capacitor reaches 1 V, the charging cycle is complete. The ALERT output then asserts (goes high). Different values of TIMER capacitor generate different time delays between current faults occurring and the ALERT output asserting. When using the ALERT output to implement a hot swap circuit, the TIMER capacitor should be chosen to generate a large enough startup delay to allow the maximum inrush current to completely charge up the load without tripping an ALERT fault.

KELVIN SENSE RESISTOR CONNECTION

When using a low value sense resistor for high current measurement, the problem of parasitic series resistance can arise. The lead resistance can be a substantial fraction of the rated resistance, making the total resistance a function of lead length.

This problem can be avoided by using a Kelvin sense connection. This type of connection separates the current path through the resistor and the voltage drop across the resistor. Figure 30 shows the correct way to connect the sense resistor between the VCC pin and the SENSE pin of the ADM1192.

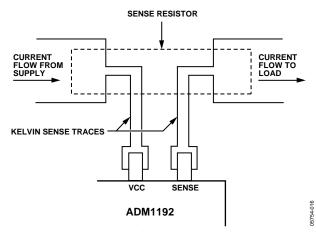
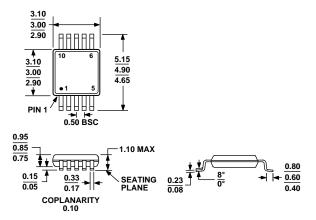


Figure 30. Kelvin Sense Connections

OUTLINE DIMENSIONS



COMPLIANT TO JEDEC STANDARDS MO-187-BA
Figure 31. 10-Lead Mini Small Outline Package [MSOP]
(RM-10)
Dimensions shown in millimeters

ORDERING GUIDE

| Model | Temperature Range | Package Description | Package Option | Branding |
|-------------------------------|-------------------|---------------------|----------------|----------|
| ADM1192-1ARMZ-R7 ¹ | -40°C to +85°C | 10-Lead MSOP | RM-10 | M5M |
| EVAL-ADM1192EBZ ¹ | | Evaluation Board | | |

¹ Z = Pb-free part.

NOTES

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